N.A. GRATTON RECEIVED CENTRAL FAX CENTER

MAR 0 8 2005

STEPHEN A. GRATTON ATTORNEY AT LAW 2764 South Braun Way Lakewood, CO 80228 Telephone: 303 989 6353 FAX: 303 989 6538

FAX Transmittal

Date: MARCH 2, 2005

Pages: 9 (including this one)

TO: Office of Petitions

FAX: (703) 872-9306

FROM: Steve Gratton

FAX: (303) 989 6538

Re: Serial no. 09/266,237 Docket No. 97-1433

See attached "Supplement To Petition To Accept Late Payment Of Issue Fee".

CONFIDENTIALITY NOTICE: This message is intended only for the use of the individual or entity to which it is addressed and may contain information that is privileged, confidential, and exempt from disclosure under applicable law. If the reader of this message is not the intended recipient, or the employee or agent responsible for delivering this message to the intended recipient, you are hereby notified that any dissemination, distribution, or copying of this communications strictly prohibited. If you have received this communication in error, please notify us immediately by telephone and return the original message to us at the above address via the US Postal Service. Thank you.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

WARREN M. FARNWORTH SALMAN AKRAM

Serial No. 09/266,237

Art Unit: 2829

RECEIVED
CENTRAL FAX CENTER

Filing Date: 03/10/1999

Examiner: KOBERT, R.

MAR 0 8 2005

For: TEST INTERCONNECT AND TEST SYSTEM

FOR BUMPED SEMICONDUCTOR COMPONENTS

(AS AMENDED)

Attorney Docket No. 97-1433

SUPPLEMENT TO PETITION TO ACCEPT LATE PAYMENT OF ISSUE FEE

MARCH 2, 2005

Mail Stop Petition Commissioner For Patents PO Box 1450 Alexandria, VA 22313-1450

Sir:

Applicant has filed a Petition To Accept Late Payment Of Issue Fee dated October 11, 2004. However, the Petition was defective in that it did not include proof that the Notice of Allowance And Fees Due mailed on 06/08/2004 was not received by the Attorney for Applicant. This Supplement is being filed with proof that the Notice of Allowance And Fees Due was a non received communication.

With respect to proof, MPEP 711.03(c)I.A, requires a statement from the Practitioner that the communication was not received, along with a copy of the docket records for the period for response indicating where the communication

would have been entered had it been received. In view of the foregoing requirements, Attorney for Applicant hereby provides the following statements and documents.

- 1. Attorney For Applicant did not receive the original "Notice Of Allowance And Fees Due" mailed on 06/08/2004 by the Patent Office.
- 2. Attorney for Applicant has searched the file jacket and the docket records for docket no. 97-1433 (serial no. 09/266,237). Both the file jacket and the docket records indicate that the above communication was not received.
- 3. Attached to this Supplement are docket records for "The Law Office Of Steve Gratton" for the period from 06/01/2004 to 10/19/2004, which includes the three month period for response (06/08/2004 to 09/08/2004) for the non received communication.
- 4. These docket records have been labeled as Exhibits A-D. Exhibit A is dated June 1, 2004. Exhibit B is dated July 21, 2004. Exhibit C is dated September 16, 2004. Exhibit D is dated October 19, 2004.
- 5. The present application docket no. 97-1433 (serial no. 09/266,237) is contained on page 6 of the docket records.

Exhibit A dated June 1, 2004 includes the entry under "ACTION DUE" for docket no. 97-1433 (serial no. 09/266,237) "Filed Amendment 4/26/04".

Exhibit B dated July 21, 2004 includes the entry under "ACTION DUE" for docket no. 97-1433 (serial no. 09/266,237)
"Filed Amendment 4/26/04".

Exhibit C dated September 16, 2004 includes the hand written entry under "ACTION DUE" for docket no. 97-1433 (serial no. 09/266,237) "Filed Issue Fee Transmittal + Petition 10/11/04".

Exhibit D dated October 19, 2004 includes the entry under "ACTION DUE" for docket no. 97-1433 (serial no. 09/266,237) "Filed Issue Fee Transmittal and Petition" 10/11/04.

6. These docket records indicate that the Notice of Allowance And Fees Due mailed on 06/08/2004 for docket no. 97-1433 (serial no. 09/266,237) was not received by Attorney for Applicant in the time period for response of (06/08/2004 to 09/08/2004).

In view of the foregoing Applicant requests that the holding of abandonment be withdrawn. In addition, Applicant requests that the "Part B-Fee(s) Transmittal", the "Fee Address Indication Form" and the issue fee be accepted and processed.

Respectfully submitted:

STEPHEN A. GATTON

Registration No. 28,418

Attorney for Applicant

2764 S. Braun Way Lakewood, CO 80228

Telephone: (303) 989-6353

FAX (303) 989~6538

CERTIFICATE OF TRANSMISSION UNDER 37 C.F.R. §1.8

I hereby certify that this correspondence entitled "Supplement to Petition To Accept Late Payment Of Issue Fee" (pages 1-4 and Exhibits A-D) is being facsimile transmitted to the United States Patent and Trademark Office on 03/02/2005 to Fax no. (571) 273-0025 for the Office of Petitions.

Date of Signature

Stephen A. Gratton Attorney for Applicant #28,418

KGD DOCKET	Test.			
CASE NO.	TITLE (SHORT)	FILING DATE	COMMENTS	ACTION DUE
97-1433	Test Interconnect For Bumped Components (Apparatus)	3/10/99	Warren, Salman	Filed Amendment 4/26/04.
97-1433.1 09/844,532	Test Interconnect For Bumped Components (Method of Fab)	4/27/01	Warren, Salman Div of 97-1433	Filed Amendment & IDS 4/30/04.
97-1433.2 10/832,483	Test Interconnect For Bumped Components	4/26/04	Warren, Salman Div of 97-1433	Awaiting OA.
99-311.1 09/834,805	Test Interconnect For Bumped Components (Method of Fab)	4/12/01	Warren, Salman Div of 99-0311	Paid Issue Fee by 3/22/04.
99-311.2	Test Interconnect for Bumped	7/18/02	Div of 99-0311	Paid Issue Fee 2/13/04. 16.///
99-311.3 10/666,292	Contact for Semiconductor Components	9/18/03	Cont of 99-0311.2	Awaiting OA.
99-0285.2 10/329,212	Interconnect With Variable Flexure (Method for Test)	12/24/02	Cont of 99-0285.1	וי ועב
99-0323.2 10/334,407	Method for Fabricating Package	12/31/02	Cont of 99-0323.1	Respond to OA by 2/18/04.*
99-068.2 09/653,366	Polymer Support Member for BGA (Method)	9/1/00	Warren, Alan Cont. of. 99-0068.1	Filed Issue Fee 3/31/04.
99-068.3 10/693,380	Polymer Support Member for BGA (Method)	10/24/03	Warren, Alan Cont of 99-0068.2	Updated IDS 2/6/04.
99-0703.1 10/187,915	Silicon Carbide Interconnect (Method)	7/1/02	Div of 99-0703	Respond to OA by 8/10/04.*
99-0703.3	Silicon Carbide Contact	9/11/03		Awaiting OA.
99-0812.2 10/659,828	Semiconductor Component Having Test Contacts	9/12/03	Cont. of 99~0812.1	Awaiting Updated
THE LAW OFFICE OF STEVE GRATION	FICE	June 1, 2004		response due Page 6

Page 6

t Settle) al ala	with Whom Ale		22/04.	04.	7/21/04.	7/21/04.	7/21/04.	7/21/04.	7/21/04.	7/21/04. /04. 04.	7/21/04. /04. IS 8/27/04.	7/21/04. /04. 08 8/27/04. IDS 9/17/04.
her ton	ACTION DUE	Frited Amondment 4/26/04	Filed Respond 7/23/04.	Awaiting OA. Paid Issue Fee by 3/22/04	Paid Issue Fee 2/13/04. Status Letter filed 7/21/04			l lä			ent 6/22/0	ent 6/22/0	ent 6/22/0 se 8/23/04 2/6/04.
	COMMENTS AC	Warren, Salman	Warren, Salman Fi Div of 97-1433	Warren, Salman Aw Div of 97-1433 Warren, Salman Pa Div of 99-0311	Div of 99-0311 Pa		Cont of 99-0311.2 Av	of 99-0311.2 of 99-0285.1	of 99-0311.2 of 99-0285.1 of 99-0323.1	of 99-0311.2 of 99-0285.1 of 99-0323.1 of 99-068.2	of 99-0311.2 of 99-0323.1 of 99-0323.1 of 99-0068.2 of 99-0703	of 99-0311.2 of 99-0323.1 of 99-0323.1 of 99-0068.2 of 99-0703	of 99-0311.2 of 99-0323.1 of 99-0323.1 of 99-0703 of 99-0703
EXHIBIT C	FILING DATE C	3/10/99	4/27/01 W	4/26/04	7/18/02		9/18/03 C	2	2 2	2 2 2	9/18/03 12/24/02 12/31/02 10/24/03	9/18/03 12/24/02 12/31/02 10/24/03 7/1/02	9/18/03 12/24/02 12/31/02 10/24/03 7/1/02 9/11/03
	TITLE (SHORT)	Test Interconnect For Bumped Components (Apparatus)	Test Interconnect For Bumped Components (Method of Fab)	Test Interconnect For Bumped Components Test Interconnect For Bumped Components (Method of Fab)	Test Interconnect for Bumped		Contact for Semiconductor Components	עעוו	Contact for Semiconductor Components Interconnect With Variable Flexure (Method for Test) Method for Fabricating Package	Contact for Semiconductor Components Interconnect With Variable Flexure (Method for Test) Method for Fabricating Package Polymer Support Member for BGA (Method)	Contact for Semiconductor Components Interconnect With Variable Flexure (Method for Test) Method for Fabricating Package Polymer Support Member for BGA (Method) Silicon Carbide Interconnect (Method)	Contact for Semiconductor Components Interconnect With Variable Flexure (Method for Test) Method for Fabricating Package Polymer Support Member for BGA (Method) Silicon Carbide Interconnect (Method) Silicon Carbide, Contact	Contact for Semiconductor Components Interconnect With Variable Flexure (Method for Test) Method for Fabricating Package Polymer Support Member for BGA (Method) Silicon Carbide Interconnect (Method) Silicon Carbide Contact Semiconductor Component Having Test Contacts
	ASE NO. TIT	7-1433 Tes	7-1433.1 Tes 9/844,532 Com	7-1433.2 Tes 0/832,483 Con 9-311.1 Tes 9/834,805 Con	9-311.2 Tee		9-311.3 Cor	, a					

July 21, 2004

KGD DOCKET

			•	•
CASE NO.	CASE NO. TITLE (SHORT) F	FILING DATE	COMMENTS	ACTION DUE
97-1433 09/266,237	Test Interconnect For Bumped Components (Apparatus)	3/10/99	Warren, Salman	Filed Amendment 4/26/04.
97-1433.1 09/844,532	Test Interconnect For Bumped Components (Method of Fab)	4/27/01	Warren, Salman Div of 97-1433	Filed Amendment & IDS 4/30/04.
97-1433.2 10/832,483	Test Interconnect For Bumped Components	4/26/04	Warren, Salman Div of 97-1433	
99-311.1 09/834,805	Test Interconnect For Bumped Components (Method of Fab)	4/12/01	Warren, Salman Div of 99-0311	Paid Issue Fee by 3/22/04.
99-311.2	Test Interconnect for Bumped	7/18/02	Div of 99-0311	Paid Issue Fee 2/13/04. Status Letter filed 7/21/04.
99-311.3 10/666,292	Contact for Semiconductor Components	9/18/03	Cont of 99-0311.2	99-0311.2 Awaiting OA.
99-0285.2 10/329,212	Interconnect With Variable Flexure (Method for Test)	12/24/02	Cont of 99-0285.1	99-0285.1 Filed Amendment 6/22/04.
99-0323.2 10/334,407	Method for Fabricating Package	12/31/02	Cont of 99-0323.1	PAID T. 30 8/2/1/2
99-068.3 10/693,380	Polymer Support Member for BGA (Method)	10/24/03	Warren, Alan Cont of 99-0068.2	
99-0703.1 10/187,915	Silicon Carbide Interconnect (Method)	7/1/02	Div of 99-0703	Mespond to lot by 8/10/04.7 + 105 9
99-0703.3 10/660,367	Silicon Carbide Contact	9/11/03		
99-0812.2 10/659,828	Semiconductor Component Having Test Contacts	9/12/03	Cont. of 99~0812.1	99-0812.1 Respond to OA by 9/17/04.*
				*Response due

*Response due

KGD DOCKET		-		
CASE NO.	TLE (SHORT)	FILING DATE	COMMENTS	ACTION DUE
97-1433 09/266,237	Test Interconnect For Bumped Components (Apparatus)	3/10/99	Warren, Salman	Filed Issue Pee Transmittal and Petition 10/11/04.
97-1433.1 09/844,532	Test Interconnect For Bumped Components (Method of Fab)	4/27/01	Warren, Salman Div of 97-1433	Filed Response 7/23/04.
97-1433.2 10/832,483	Test Interconnect For Bumped Components	4/26/04	Warren, Salman Div of 97-1433	Awaiting OA.
99-311.1 09/834,805	Test Interconnect For Bumped Components (Method of Fab)	4/12/01	Warren, Salman Div of 99-0311	Paid Issue Fee 3/22/04.
99-311.2	Test Interconnect for Bumped	7/18/02	Div of 99-0311	Paid Issue Fee 2/13/04. Status Letter filed 7/21/04.
99-311.3 10/666,292	Contact for Semiconductor Components	9/18/03	Cont of 99-0311.2	99-0311.2 Awaiting OA.
99-0285.2 10/329,212	Interconnect With Variable Flexure (Method for Test)	12/24/02	Cont of 99-0285.1	Filed Amendment 6/32/04.
99-0323.2 10/334,407	Method for Fabricating Fackage	12/31/02	Cont of 99-0323.1	Cont of 99-0323.1 Paid Issue Fee 8/23/04.
99-068.3 10/693,380	Polymer Support Member for BGA (Method)	10/24/03	Warren, Alan Cont of 99-0068.2	Updated IDS 2/6/04.
99-0703.1 10/187,915	Silicon Carbide Interconnect (Method)	7/1/02	Div of 99-0703	Riled Amendment & IDS 8/27/04. Reapond to Dit by 2/10/25
99-0703.3 10/660,367	Silicon Carbide Contact	9/11/03		Awaiting OA.
99-0812.2 10/659,828	Semiconductor Component Having Test Contacts	9/12/03	Cont. of 99-0812.	of 99-0812.1 Filed Amendment & IDS 9/17/04.
				*Response due